

**Search Notes**

Application/Control No.

10/085,607

Examiner

Monica Lewis

Applicant(s)/Patent under  
Reexamination

HAYASHI ET AL.

Art Unit

2822

**SEARCHED**

Class	Subclass	Date	Examiner
257	57,59, 72,79, 80,84	10/29/2005	ML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search		10/29/2005	ML

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EIC Search	10/29/2005	ML
East Search	10/29/2005	ML